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### Amendments to the Claims

This listing of claims replaces all prior versions and listings of claims in the application.

## **Listing of Claims**

- 1-5. (Canceled)
- 6. (Currently Amended) A method of manufacturing a light emitting device, said method comprising:

forming at least a transparent protrusion;

forming a pixel electrode to overlap the transparent protrusion;

forming an organic a light emitting layer to overlap the pixel electrode; and

forming a cathode over the organic light emitting layer.

7. (Currently Amended) A personal computer comprising a main body, a casing, a display portion, and a keyboard, said personal computer including using a light emitting device: wherein said light emitting device comprises:

at least a transparent protrusion;

a pixel electrode over the transparent protrusion;

an organic a light emitting layer over the pixel electrode; and

a cathode over the organic light emitting layer,

wherein a surface of the cathode in contact with the organic light emitting layer is uneven.

8. (Original) A personal computer according to claim 7, further comprising: an insulating film in transverse direction of the transparent protrusion, wherein the insulating film has a high light absorption property.

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9. (Original) A personal computer according to claim 7, wherein the transparent protrusion is a microlens.

10. (Currently Amended) A portable telephone comprising a main body, a sound output portion, a sound input portion, a display portion, operation switches, and an antenna, said portable telephone including using a light emitting device:

wherein said light emitting device comprises:

at least a transparent protrusion;
a pixel electrode over the transparent protrusion;
an organie a light emitting layer over the pixel electrode; and
a cathode over the organie light emitting layer,

wherein a surface of the cathode in contact with the <del>organic</del> <u>light emitting</u> layer is uneven.

- 11. (Original) A portable telephone according to claim 10, further comprising: an insulating film in a transverse direction of the transparent protrusion, wherein the insulating film has a high light absorption property.
- 12. (Original) A portable telephone according to claim 10, wherein the transparent protrusion is a microlens.
- 13. (Original) A portable telephone according to claim 10, further comprising an operation panel, a connecting portion, and a power source switch.
- 14. (Previously presented) A method according to claim 6, further comprising: forming an insulating film in a transverse direction of the transparent protrusion, wherein the insulating film has a high light absorption property.

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15. (Currently Amended) A method according to claim 6, further comprising:

forming a thin film transistor on a substrate, wherein the thin film transistor comprises a semiconductor film and a gate electrode;

forming an insulating film over the thin film transistor;

forming a first opening in the insulating film;

forming a [[wire]] <u>wiring</u> over the insulating film, wherein the [[wire]] <u>wiring</u> is electrically connected to the semiconductor film through the first opening; and forming at least one second opening in the insulating film.

16. (Currently Amended) A method according to claim 6, further comprising:

forming a thin film transistor on a substrate, wherein the thin film transistor comprises a semiconductor film and a gate electrode;

forming an insulating film over the thin film transistor, wherein the insulating film has a high light absorption property;

forming a first opening in the insulating film;

forming a [[wire]] <u>wiring</u> over the insulating film, wherein the [[wire]] <u>wiring</u> is electrically connected to the semiconductor film through the first opening; and forming at least one second opening in the insulating film.

17. (Currently Amended) A method according to claim 6, further comprising:

forming a thin film transistor on a substrate, wherein the thin film transistor comprises a semiconductor film and a gate electrode;

forming a first insulating film over the thin film transistor;

forming a first opening in the first insulating film;

forming a [[wire]] <u>wiring</u> over the first insulating film, wherein the [[wire]] <u>wiring</u> is electrically connected to the semiconductor film through the first opening;

forming a second insulating film in contact with the first insulating film; and

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forming a second opening in the second insulating film.

18. (Currently Amended) A method according to claim 6, further comprising:

forming a thin film transistor on a substrate, wherein the thin film transistor comprises a semiconductor film and a gate electrode;

forming a first insulating film over the thin film transistor;

forming a first opening in the first insulating film;

forming a [[wire]] <u>wiring</u> over the first insulating film, wherein the [[wire]] <u>wiring</u> is electrically connected to the semiconductor film through the first opening;

forming a second insulating film in contact with the first insulating film, wherein the second insulating film has a high light absorption property; and

forming a second opening in the second insulating film.

- 19. (Currently Amended) A method according to claim 6, wherein the transparent protrusion includes comprises a microlens.
- 20. (New) A method according to claim 6, wherein the light emitting layer comprises at least one of an organic material and an inorganic material.
- 21. (New) A method according to claim 6, wherein a surface of the cathode in contact with the light emitting layer is uneven.
- 22. (New) A personal computer according to claim 7, wherein the light emitting layer comprises at least one of an organic material and an inorganic material.
- 23. (New) A portable telephone according to claim 10, wherein the light emitting layer comprises at least one of an organic material and an inorganic material.

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24. (New) A method of manufacturing a light emitting device, said method comprising:

forming at least a protrusion having a property of transmitting light;

forming a pixel electrode to overlap the protrusion;

forming a light emitting layer to overlap the pixel electrode; and

forming a cathode over the light emitting layer.

25. (New) A method according to claim 24, further comprising:

forming an insulating film in a transverse direction of the protrusion, wherein the insulating film has a high light absorption property.

26. (New) A method according to claim 24, further comprising:

forming a thin film transistor on a substrate, wherein the thin film transistor comprises a semiconductor film and a gate electrode;

forming an insulating film over the thin film transistor;

forming a first opening in the insulating film;

forming a wiring over the insulating film, wherein the wiring is electrically connected to the semiconductor film through the first opening; and

forming at least one second opening in the insulating film.

27. (New) A method according to claim 24, further comprising:

forming a thin film transistor on a substrate, wherein the thin film transistor comprises a semiconductor film and a gate electrode;

forming an insulating film over the thin film transistor, wherein the insulating film has a high light absorption property;

forming a first opening in the insulating film;

forming a wiring over the insulating film, wherein the wiring is electrically connected to the semiconductor film through the first opening; and

forming at least one second opening in the insulating film.

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28. (New) A method according to claim 24, further comprising:

forming a thin film transistor on a substrate, wherein the thin film transistor comprises a semiconductor film and a gate electrode;

forming a first insulating film over the thin film transistor;

forming a first opening in the first insulating film;

forming a wiring over the first insulating film, wherein the wiring is electrically connected to the semiconductor film through the first opening;

forming a second insulating film in contact with the first insulating film; and forming a second opening in the second insulating film.

29. (New) A method according to claim 24, further comprising:

forming a thin film transistor on a substrate, wherein the thin film transistor comprises a semiconductor film and a gate electrode;

forming a first insulating film over the thin film transistor;

forming a first opening in the first insulating film;

forming a wiring over the first insulating film, wherein the wiring is electrically connected to the semiconductor film through the first opening;

forming a second insulating film in contact with the first insulating film, wherein the second insulating film has a high light absorption property; and

forming a second opening in the second insulating film.

- 30. (New) A method according to claim 24, wherein the light emitting layer comprises at least one of an organic material and an inorganic material.
- 31. (New) A method according to claim 24, wherein a surface of the cathode in contact with the light emitting layer is uneven.

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32. (New) A method of manufacturing a light emitting device, said method comprising:

forming at least a microlens;

forming a pixel electrode to overlap the microlens;

forming a light emitting layer to overlap the pixel electrode; and

forming a cathode over the light emitting layer.

33. (New) A method according to claim 32, further comprising:

forming an insulating film in a transverse direction of the microlens, wherein the insulating film has a high light absorption property.

34. (New) A method according to claim 32, further comprising:

forming a thin film transistor on a substrate, wherein the thin film transistor comprises a semiconductor film and a gate electrode;

forming an insulating film over the thin film transistor;

forming a first opening in the insulating film;

forming a wiring over the insulating film, wherein the wiring is electrically connected to the semiconductor film through the first opening; and

forming at least one second opening in the insulating film.

35. (New) A method according to claim 32, further comprising:

forming a thin film transistor on a substrate, wherein the thin film transistor comprises a semiconductor film and a gate electrode;

forming an insulating film over the thin film transistor, wherein the insulating film has a high light absorption property;

forming a first opening in the insulating film;

forming a wiring over the insulating film, wherein the wiring is electrically connected to the semiconductor film through the first opening; and

forming at least one second opening in the insulating film.

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36. (New) A method according to claim 32, further comprising:

forming a thin film transistor on a substrate, wherein the thin film transistor comprises a semiconductor film and a gate electrode;

forming a first insulating film over the thin film transistor;

forming a first opening in the first insulating film;

forming a wiring over the first insulating film, wherein the wiring is electrically connected to the semiconductor film through the first opening;

forming a second insulating film in contact with the first insulating film; and forming a second opening in the second insulating film.

37. (New) A method according to claim 32, further comprising:

forming a thin film transistor on a substrate, wherein the thin film transistor comprises a semiconductor film and a gate electrode;

forming a first insulating film over the thin film transistor;

forming a first opening in the first insulating film;

forming a wiring over the first insulating film, wherein the wiring is electrically connected to the semiconductor film through the first opening;

forming a second insulating film in contact with the first insulating film, wherein the second insulating film has a high light absorption property; and

forming a second opening in the second insulating film.

- 38. (New) A method according to claim 32, wherein the light emitting layer comprises at least one of an organic material and an inorganic material.
- 39. (New) A method according to claim 32, wherein a surface of the cathode in contact with the light emitting layer is uneven.

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40. (New) A method of manufacturing a light emitting device, said method comprising:

forming at least a layer containing a transparent material;

forming a pixel electrode to overlap the layer;

forming a light emitting layer to overlap the pixel electrode; and

forming a cathode over the light emitting layer,

wherein a surface of the cathode in contact with the light emitting layer is uneven.

41. (New) A method according to claim 40, further comprising:

forming an insulating film in a transverse direction of the layer, wherein the insulating film has a high light absorption property.

42. (New) A method according to claim 40, further comprising:

forming a thin film transistor on a substrate, wherein the thin film transistor comprises a semiconductor film and a gate electrode;

forming an insulating film over the thin film transistor;

forming a first opening in the insulating film;

forming a wiring over the insulating film, wherein the wiring is electrically connected to the semiconductor film through the first opening; and

forming at least one second opening in the insulating film.

43. (New) A method according to claim 40, further comprising:

forming a thin film transistor on a substrate, wherein the thin film transistor comprises a semiconductor film and a gate electrode;

forming an insulating film over the thin film transistor, wherein the insulating film has a high light absorption property;

forming a first opening in the insulating film;

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forming a wiring over the insulating film, wherein the wiring is electrically connected to the semiconductor film through the first opening; and

forming at least one second opening in the insulating film.

### 44. (New) A method according to claim 40, further comprising:

forming a thin film transistor on a substrate, wherein the thin film transistor comprises a semiconductor film and a gate electrode;

forming a first insulating film over the thin film transistor;

forming a first opening in the first insulating film;

forming a wiring over the first insulating film, wherein the wiring is electrically connected to the semiconductor film through the first opening;

forming a second insulating film in contact with the first insulating film; and forming a second opening in the second insulating film.

# 45. (New) A method according to claim 40, further comprising:

forming a thin film transistor on a substrate, wherein the thin film transistor comprises a semiconductor film and a gate electrode;

forming a first insulating film over the thin film transistor;

forming a first opening in the first insulating film;

forming a wiring over the first insulating film, wherein the wiring is electrically connected to the semiconductor film through the first opening;

forming a second insulating film in contact with the first insulating film, wherein the second insulating film has a high light absorption property; and

forming a second opening in the second insulating film.

46. (New) A method according to claim 40, wherein the light emitting layer comprises at least one of an organic material and an inorganic material.

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47. (New) A method according to claim 40, wherein the layer has a protrusion.

48. (New) A method of manufacturing a light emitting device, said method comprising:

forming at least a layer having a property of transmitting light,

forming a pixel electrode to overlap the layer;

forming a light emitting layer to overlap the pixel electrode; and

forming a cathode over the light emitting layer,

wherein a surface of the cathode in contact with the light emitting layer is uneven.

49. (New) A method according to claim 48, further comprising:

forming an insulating film in a transverse direction of the layer, wherein the insulating film has a high light absorption property.

50. (New) A method according to claim 48, further comprising:

forming a thin film transistor on a substrate, wherein the thin film transistor comprises a semiconductor film and a gate electrode;

forming an insulating film over the thin film transistor;

forming a first opening in the insulating film;

forming a wiring over the insulating film, wherein the wiring is electrically connected to the semiconductor film through the first opening; and

forming at least one second opening in the insulating film.

51. (New) A method according to claim 48, further comprising:

forming a thin film transistor on a substrate, wherein the thin film transistor comprises a semiconductor film and a gate electrode;

forming an insulating film over the thin film transistor, wherein the insulating film has a high light absorption property;

forming a first opening in the insulating film;

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forming a wiring over the insulating film, wherein the wiring is electrically connected to the semiconductor film through the first opening; and

forming at least one second opening in the insulating film.

## 52. (New) A method according to claim 48, further comprising:

forming a thin film transistor on a substrate, wherein the thin film transistor comprises a semiconductor film and a gate electrode;

forming a first insulating film over the thin film transistor;

forming a first opening in the first insulating film;

forming a wiring over the first insulating film, wherein the wiring is electrically connected to the semiconductor film through the first opening;

forming a second insulating film in contact with the first insulating film; and forming a second opening in the second insulating film.

## 53. (New) A method according to claim 48, further comprising:

forming a thin film transistor on a substrate, wherein the thin film transistor comprises a semiconductor film and a gate electrode;

forming a first insulating film over the thin film transistor;

forming a first opening in the first insulating film;

forming a wiring over the first insulating film, wherein the wiring is electrically connected to the semiconductor film through the first opening;

forming a second insulating film in contact with the first insulating film, wherein the second insulating film has a high light absorption property; and

forming a second opening in the second insulating film.

54. (New) A method according to claim 48, wherein the light emitting layer comprises at least one of an organic material and an inorganic material.

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55. (New) A method according to claim 48, wherein the layer has a protrusion.

56. (New) A method according to claim 48, wherein the layer contains a transparent material.